

Soft X-Ray Instrumentation at the European XFEL

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- Soft X-rays at the European XFEL
- Scientific Instruments in the Soft X-ray regime
 - **SQS Scientific Instruments**
 - **SCS Scientific Instruments**
- Infra-structure

optical laser, diagnostics, add-on equipment, time line



XFEL European X-ray Free Electron Laser



XFEL European X-ray Free Electron Laser





XFEL Electron and Photon beam transport systems



Undulators at the European XFEL



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XFEL Les Instruments Scientifiques



XFEL Photon energy ranges







XFEL SASE 3 Undulator

General Soft X-Ray radiation parameters

Pulse widths	2 – 100 fs	Coherence time	0.3 – 1.8 fs
Pulse energy	0.2 – 11.0 mJ	Bandwidth	0.25 – 0.7 %
Peak power	50 – 120 GW	Number of photons	0.1 – 2 x 10 ¹⁴
Average power	3 – 300 W	Average flux of photons	0.3 – 5.4 x 10 ¹⁸
Beam size	40 – 80 μm	Average brilliance	0.03 – 2.6 x 10 ²⁴
Rep. rate	10 Hz (2700 pulses in bunch train)		

Parameter	Unit					
Bunch charge	рС	20	100	250	500	1000
Pulse duration (FWHM)	fs	2	9	23	43	107

European XFEL



Optical layout of the beam transport system (H. Sinn)

direct beam

- \rightarrow Small Quantum System (SQS)
- monochromatized
- → Spectroscopy @ Coherent Scattering (SCS)







SQS

"Small Quantum Systems" Scientific Instrument

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XFEL Scientific Applications

SQS – Small Quantum Systems –

Investigation of atoms, ions, molecules and clusters in intense fields and non-linear phenomena

Non-linear phenomena, multi-photon **High intensities:** >10¹⁵ W/cm² Ultra-fast dynamics, pump-probe Short pulses: 2 - 100 fs **High flux** > 10^{12} photons / pulse Extremely dilute targets, Processes with small cross section $> 10^{15}$ photons / sec **Coherent Diffraction Imaging Spatial coherence** Threshold phenomena **Soft X-Ray** photon energies C(1s)=290 eV, N(1s)=410eV, O(1s)=560eV **International Workshop:** Aarhus, Denmark, October 29 - 31, 2008 Trieste, Italy, December 16 - 17, 2010

XFEL Two-color studies



Example: Two-color Pump-Probe

Optically induced electron interferences in the angular distribution



XFEL Ultra-fast processes

Diatomic molecules



molecules "fixed-in-space"

Complex Molecules

Ullrich et al. , ASG MPI Heidelberg



complete characterization = multiple coincidences

coincidences: 🛑

high (> kHz) repetition rate



XFEL SQS end-station



Gas phase targets:

- Molecular beam (atoms & molecules) supersonic jet, effusive jet, cells
- Cluster beam (mass-selected)
- Nano-particles, Nano-crystals, bio-molecules (aerosols, liquid jet)

Particle analyzers:

- High-resolution TOFs
- High resolution X-ray spectrometer
- Magnetic Bottle Electron Spectrometer
- Velocity-Map-Imaging
- Reaction Microscope
- Thomson Parabola



AQS (Atomic-like Quantum Systems) Chamber

NQS (Nano-size Quantum Systems) Chamber



XFEL SQS end-station

AQS - Chamber





XFEL SQS end-station





XFEL SQS end-station



NQS - Chamber







XFEL Optical Laser (M. Lederer)



Intra-Burst:

European

- 2700 pulses
- $f_{intra-burst} = 0.1...4.5 \text{ MHz}$
- 1mJ per pulse at 1MHz
- τ_{FWHM} = 10 ... 100fs
- \approx 10 fs jitter (rms)

Collaboration DESY, European XFEL, CFEL

"Burst Energy": ... 1J "Burst-Power": ... 1kW "Average Power": ... 10W

Pump-Probe Laser	Alignment Laser			
1 - 4.5 MHz rep. rate	100 kHz rep. rate			
0.2 – 1 mJ pulse energy	1 – 250 mJ pulse energy			
10 - 100 fs pulse duration	30 fs / 1 ns pulse duration			
< 10 fs synchronization	< 10 fs synchronization			

<u>Option</u>: 800 nm, 100 kHz, 20 – 100fs, 10mJ 1030 nm, 100 kHz, 1 ns, 250 mJ

SQS Specific

- OPA (200 3000 nm)
- variable polarization
- THz radiation
- beam characterization
- pulse stretcher



EuropeanXFELDiagnostics





FEL beam parameters for experiments

single shot / "on-line"

1. pulse energy: ± 1% (rel.)

Gas Monitor Detector (GMD)

2. arrival time: < 10fs

Reflectivity change (10 Hz),

THz – electron streaking

3. wavelength: $\Delta\lambda / \lambda = 10^{-3}$

Photoelectron Spectrometer

4. spectral profile: $\Delta\lambda / \lambda = 10^{-4}$

VLS-grating monochromator

single shot / "off-line"

- 5. pulse duration: ∆T = < 10 fs auto-correlator cross-correlation
- 6. spatial profile extended beam on CCD
- 7. temporal profile

N.N., THz electron streaking ?

8. beam position: 1 μm

YAG screens





SCS

"Spectroscopy & Coherent Scattering" Scientific Instrument

European XFEL



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EuropeanXFELSCS Scientific instrument



Spectroscopy & Coherent Scattering (SCS)

International Workshop:

Villingen, Switzerland, June 2 - 4, 2009 Trieste, Italy, December 16 - 17, 2010

Spectroscopies (electron, photon)

Imaging, Dynamics & PCS: Bio & Nano Objects

Imaging, Dynamics & PCS: Magn. Systems

Scientific applications & experimental techniques:

- Electronic and atomic structure and dynamics solids, surfaces, nano-systems, biological objects
- X-ray spectroscopy (XAS, XES, IXS, RIXS, XPS), imaging (holography, CDI, XPCS); Pump-probe experiments

Variable polarization !!









VLS (Variable Line Spacing) Grating





European

XFEL Soft X-Ray Monochromator (H. Sinn)



Temporal Resolution





Final definiton of parameters and layout (in progress): H. Sinn, R. Follath, M. Izquierdo, J. Gaudin, S. Molodtsov,

XFEL Time-resolved RIXS



The liquid-liquid phase transition in silicon revealed by snapshots of valence electrons M. Beye, F. Sorgenfrei, W. F. Schlotter, W. Wurth, A. Föhlisch, PNAS 2010 107 (39) 16772-16776







European **Electron Phonon Interactions**



Ultrafast melting of a charge density wave in the Mott Insulator 1T-TaS₂





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Momentum-resolved X-ray Scattering

XFEL Spectroscopy at LCLS



Roll on – Roll off

EBIT

- A. Nilsson D. Nordlund
- H. Ogasawara

Ph. Wernet A. Föhlisch S. Techert

Femtosecond time-resolved x-ray emission spectroscopy of liquid samples







M. Meyer, NSO at FLASH, October 13, 2011



M. Meyer, NSO at FLASH, October 13, 2011



M. Meyer, NSO at FLASH, October 13, 2011



EuropeanXFELTimeline



SQS Instrument	https://www.xfel.eu/research/instruments/sqs
Conceptual Design Repo	ort April 2011
Technical Design Report	October 2012
SCS Instrument	
Conceptual Design Repo	ort Spring 2012
Technical Design Report	Spring 2013
Installation in experimenta	I hall mid 2014
Ready for beam	mid 2015











Thank you for your attention!